

# SLM50N06T

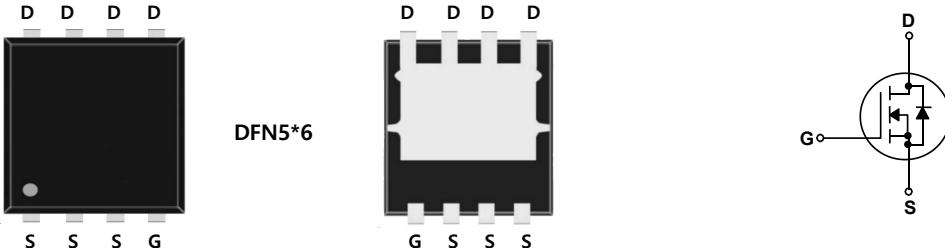
## 60V N -Channel MOSFET

### General Description

This Power MOSFET is produced using Maple semi's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as DC/DC converters and high efficiency switching for power management in portable and battery operated products.

### Features

- 50A, 60V,  $R_{DS(on)TPY} = 18m\Omega @ V_{GS} = 10V$
- Low gate charge ( typical 33nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings

$T_c = 25^\circ C$  unless otherwise noted

Symbol	Parameter	SLM50N06T	Units
$V_{DSS}$	Drain-Source Voltage	60	V
$I_D$	Drain Current - Continuous ( $T_c = 25^\circ C$ )	50 *	A
	- Continuous ( $T_c = 100^\circ C$ )	30 *	A
$I_{DM}$	Drain Current - Pulsed	(Note 1)	A
$V_{GSS}$	Gate-Source Voltage	$\pm 30$	V
EAS	Single Pulsed Avalanche Energy	(Note 2)	mJ
$I_{AR}$	Avalanche Current	(Note 1)	A
$E_{AR}$	Repetitive Avalanche Energy	(Note 1)	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$	(Note 3)	V/ns
$P_D$	Power Dissipation ( $T_c = 25^\circ C$ )	47	W
	- Derate above $25^\circ C$	0.31	W/ $^\circ C$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +175	$^\circ C$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ C$

\* Drain current limited by maximum junction temperature.

### Thermal Characteristics

Symbol	Parameter	SLM50N06T	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	3.25	$^\circ C/W$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	--	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	$^\circ C/W$

## Electrical Characteristics

$T_c = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	60	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$	--	0.06	--	$^\circ\text{C}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 60 \text{ V}$ , $V_{\text{GS}} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
		$V_{\text{DS}} = 48 \text{ V}$ , $T_c = 150^\circ\text{C}$	--	--	10	$\mu\text{A}$
$I_{\text{GSSF}}$	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 25 \text{ V}$ , $V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
$I_{\text{GSSR}}$	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -25 \text{ V}$ , $V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

## On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250 \mu\text{A}$	2.0	--	4.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}$ , $I_D = 25 \text{ A}$	--	18	22	$\text{m}\Omega$
$g_{\text{FS}}$	Forward Transconductance	$V_{\text{DS}} = 25 \text{ V}$ , $I_D = 25 \text{ A}$ (Note 4)	--	22	--	S

## Dynamic Characteristics

$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = 25 \text{ V}$ , $V_{\text{GS}} = 0 \text{ V}$ , $f = 1.0 \text{ MHz}$	--	1300	--	pF
$C_{\text{oss}}$	Output Capacitance		--	520	--	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	75	--	pF

## Switching Characteristics

$t_{d(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}} = 30 \text{ V}$ , $I_D = 25 \text{ A}$ , $R_G = 25 \Omega$ (Note 4, 5)	--	15	--	ns
$t_r$	Turn-On Rise Time		--	105	--	ns
$t_{d(\text{off})}$	Turn-Off Delay Time		--	60	--	ns
$t_f$	Turn-Off Fall Time		--	65	--	ns
$Q_g$	Total Gate Charge	$V_{\text{DS}} = 48 \text{ V}$ , $I_D = 50 \text{ A}$ , $V_{\text{GS}} = 10 \text{ V}$ (Note 4, 5)	--	33	--	nC
$Q_{\text{gs}}$	Gate-Source Charge		--	8.5	--	nC
$Q_{\text{gd}}$	Gate-Drain Charge		--	14	--	nC

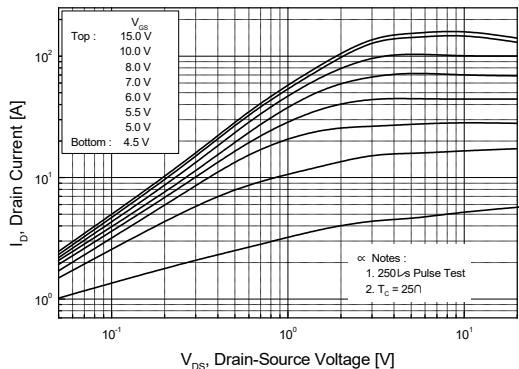
## Drain-Source Diode Characteristics and Maximum Ratings

$I_s$	Maximum Continuous Drain-Source Diode Forward Current	--	--	50	A	
$I_{\text{SM}}$	Maximum Pulsed Drain-Source Diode Forward Current	--	--	200	A	
$V_{\text{SD}}$	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}$ , $I_s = 50 \text{ A}$	--	--	1.4	V
$t_{rr}$	Reverse Recovery Time	$V_{\text{GS}} = 0 \text{ V}$ , $I_s = 50 \text{ A}$ , $dI_F / dt = 100 \text{ A/us}$ (Note 4)	--	60	--	ns
$Q_{\text{rr}}$	Reverse Recovery Charge		--	80	--	nC

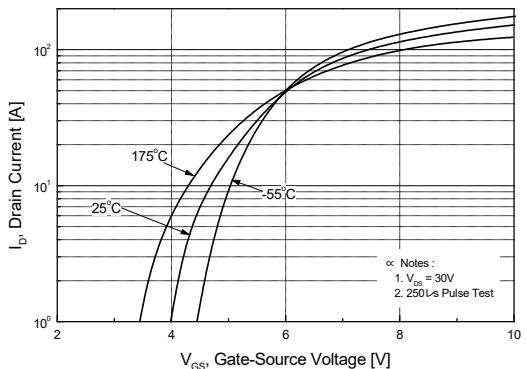
### Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $I_{\text{AS}} = 50 \text{ A}$ ,  $V_{\text{DD}} = 50 \text{ V}$ ,  $R_G = 25 \Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{\text{SD}} \leq 50 \text{ A}$ ,  $dI/dt \leq 200 \text{ A/us}$ ,  $V_{\text{DD}} \leq \text{BV}_{\text{DSS}}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width  $\leq 300 \mu\text{s}$ , Duty cycle  $\leq 2\%$
5. Essentially independent of operating temperature

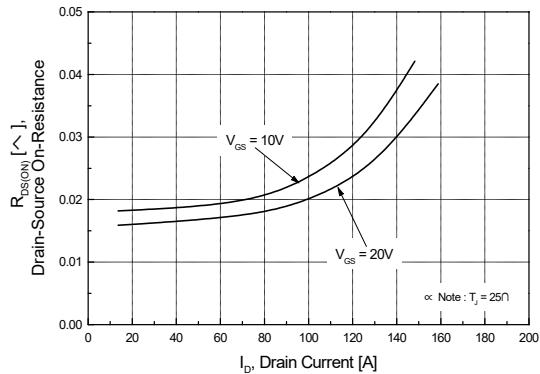
## Typical Characteristics



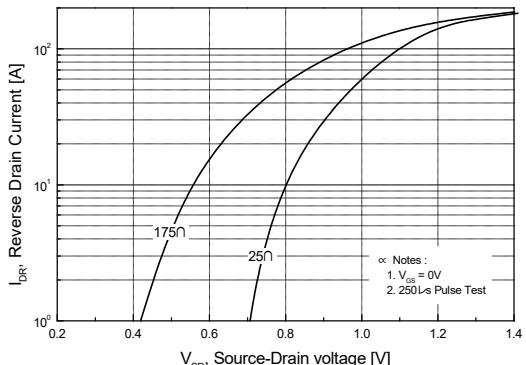
**Figure 1. On-Region Characteristics**



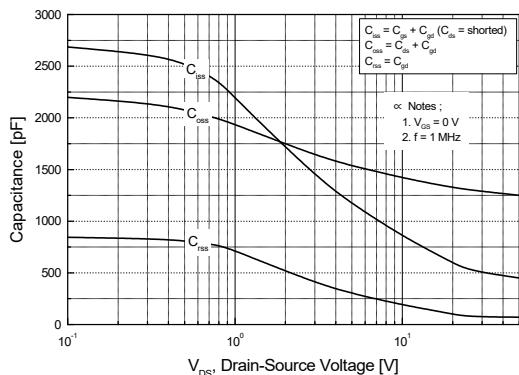
**Figure 2. Transfer Characteristics**



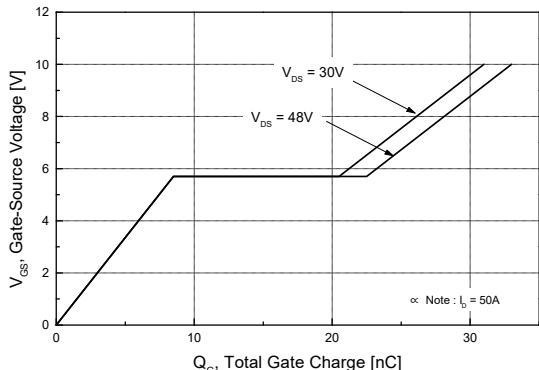
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

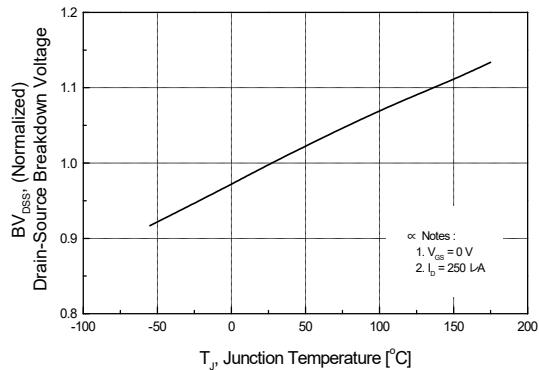


**Figure 5. Capacitance Characteristics**

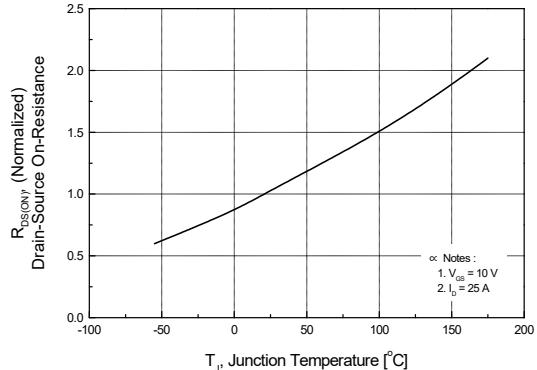


**Figure 6. Gate Charge Characteristics**

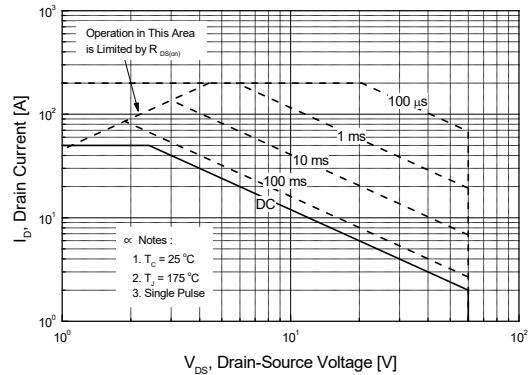
## Typical Characteristics (Continued)



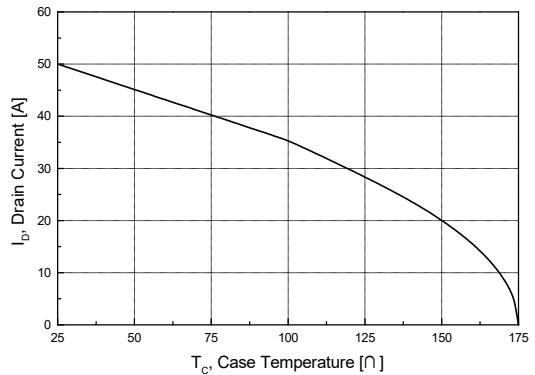
**Figure 7. Breakdown Voltage Variation vs Temperature**



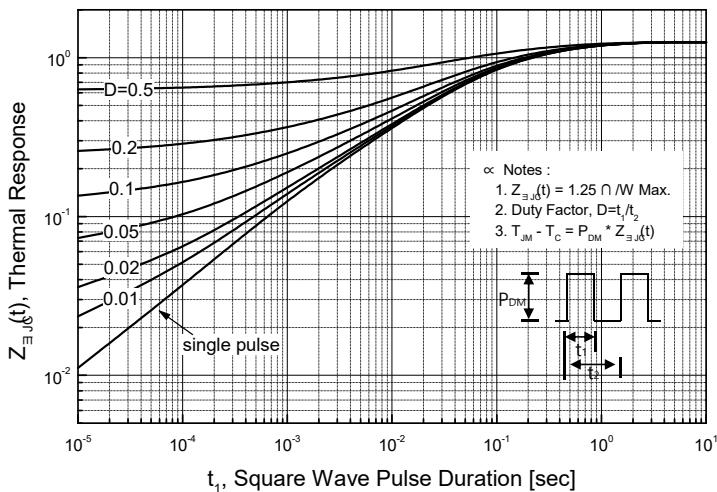
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9-1. Maximum Safe Operating Area**

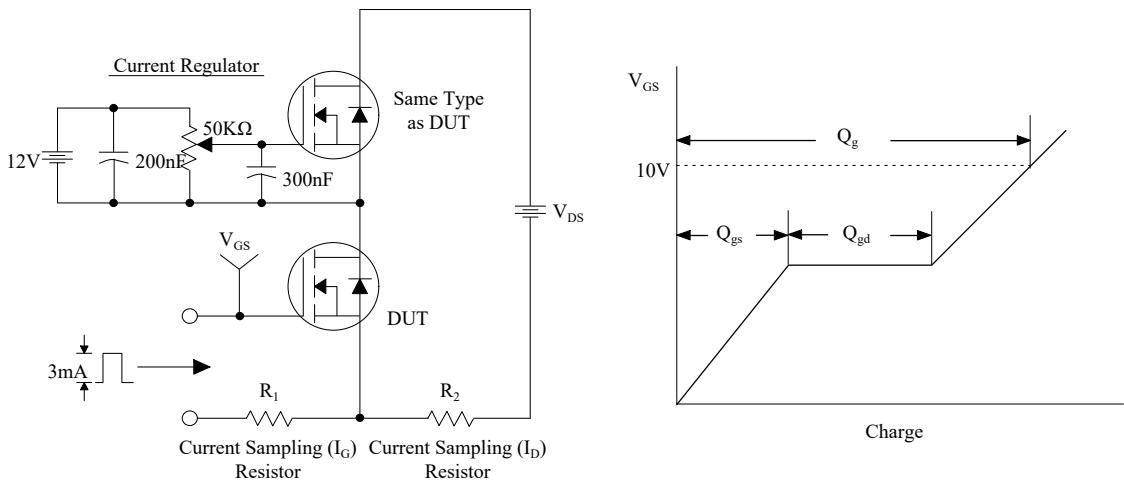


**Figure 10. Maximum Drain Current vs Case Temperature**

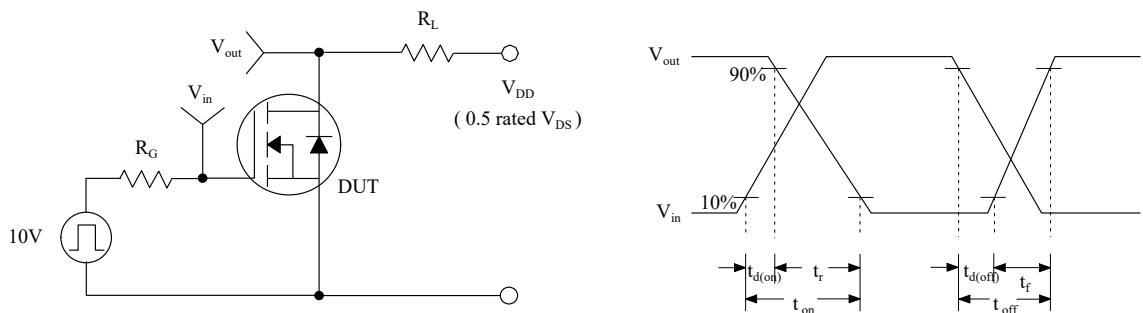


**Figure 10. Transient Thermal Response Curve**

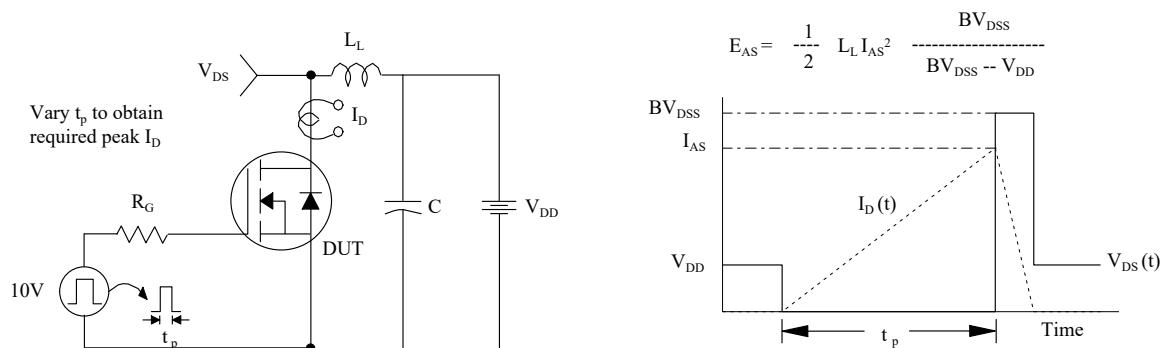
## Gate Charge Test Circuit & Waveform



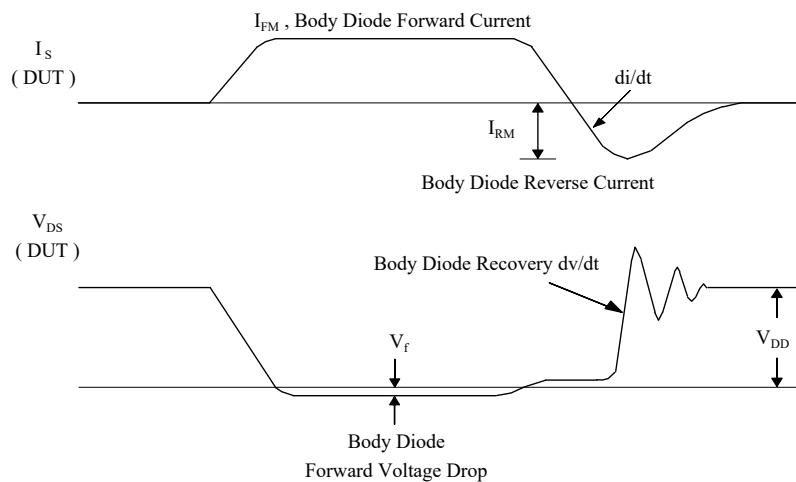
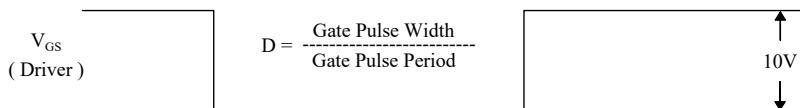
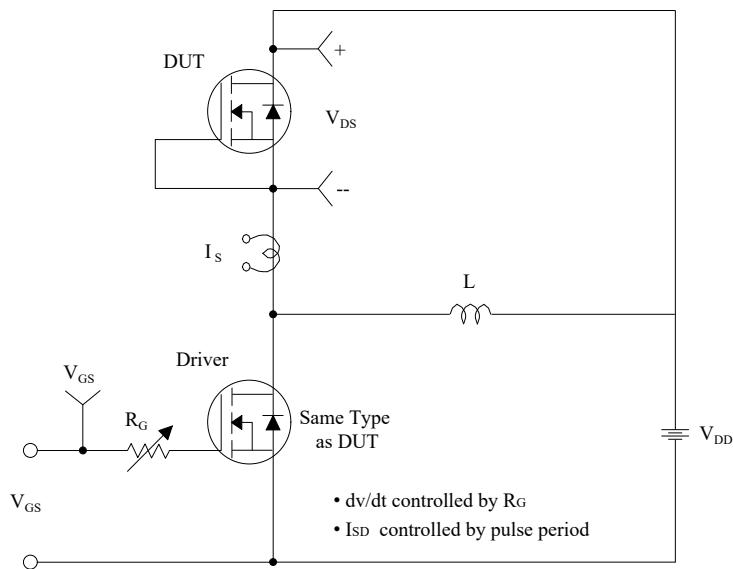
## Resistive Switching Test Circuit & Waveforms



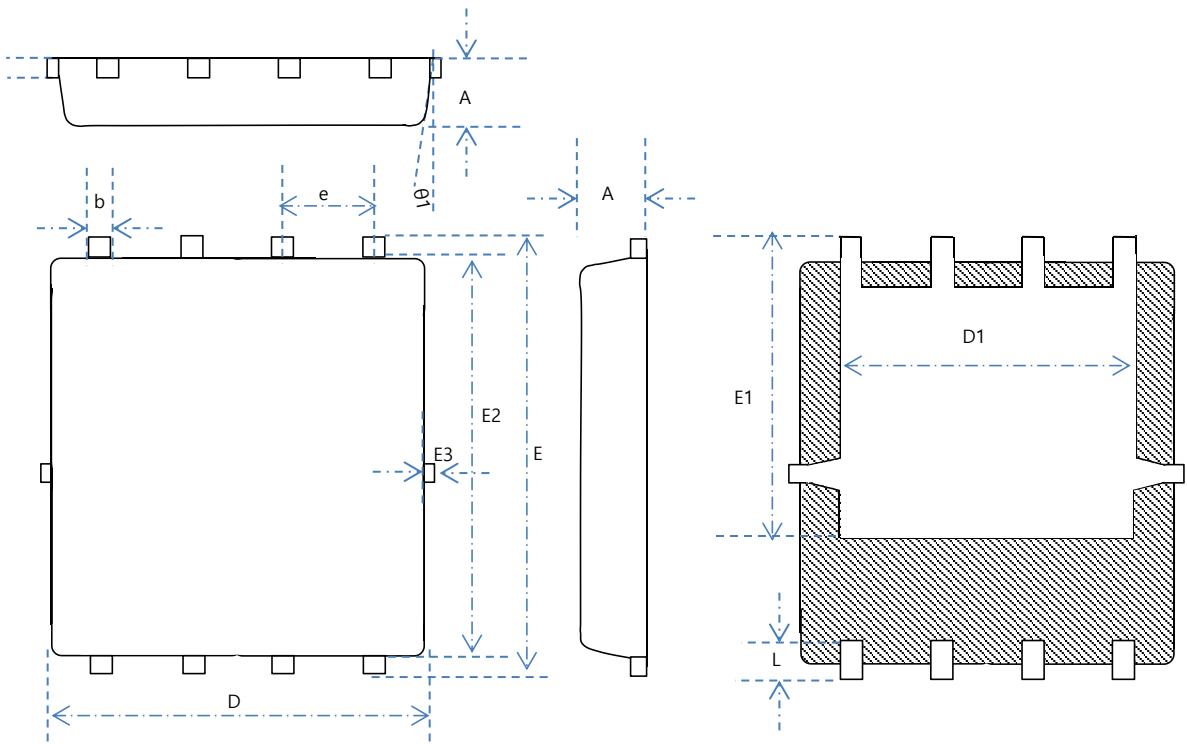
## Unclamped Inductive Switching Test Circuit & Waveforms



## Peak Diode Recovery dv/dt Test Circuit & Waveforms



# DFN 5\*6 OUTLINE



SYMBOL	Mechanical Dimensions/mm			SYMBOL	Mechanical Dimensions/mm		
	MIN	NOM	MAX		MIN	NOM	MAX
A	0.85	0.95	1.05	D	5.10	5.20	5.30
A1	0.254 REF			e	1.270 TYPE		
b	-	0.30	-	D1	3.90	4.0	4.10
E	5.85	6.05	6.25	L	0.54	0.64	0.74
E1	3.90	4.10	4.30	θ1	8°	10°	12°
E2	5.45	5.55	5.65				
E3	-	-	0.15				

单击下面可查看定价，库存，交付和生命周期等信息

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